

| _ | Application/Control No. | Applicant(s)/Patent under Reexamination |
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| | 09/940,679 | RIAZIAT ET AL. |
| | Examiner | Art Unit |
| | John P. Lacvk | 3735 |

| | SEAR | CHED | |
|-------|----------|------------|----------|
| Class | Subclass | Date | Examiner |
| 128 | 897-899 | | |
| 600 | 407,414, | | |
| , | 415 | 10/14/2005 | JPL |
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| SEARCH NOTES (INCLUDING SEARCH STRATEGY) | | | | |
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| | DATE | EXMR | | |
| See East search | 10/17/2005 | JPL | | |
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